

**Search Notes**

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TAN X. DINH

Applicant(s)/Patent under  
Reexamination

AUWENS ET AL.

Art Unit

2627

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

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**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (see search history printout)	6/19/2006	T.D